



Texas Instruments

China Power Reference Design

PMP4357 Test Procedure

REV A

2/16/2013

1 General

1.1 PURPOSE

To provide detailed data for evaluating and verifying the PMP4357 using TI DC/DC converter LM5006
LM5006 operating frequency is 300 KHz

1.2 SPECIFICATIONS

Vin: 20V-75V

Vo1: 15V, 0.3A

Vo2: 14.5V, 0.3A

1.3 TEST EQUIPMENTS

DC Source: GPS3030C

E-load: Chroma6314A frame and 63103A, 63110A module

Oscilloscope: TDS3034C

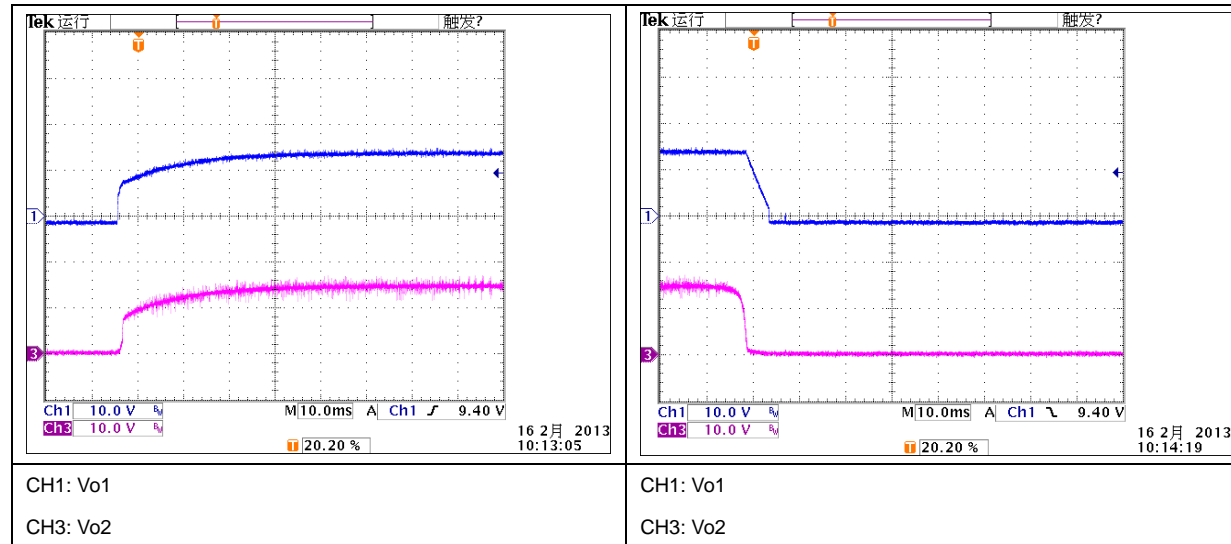
Multi-meter(current): Fluke 8845A

Multi-meter(voltage): Fluke 287C, Fluke 17B

2 OUTPUT CHARACTERISTICS

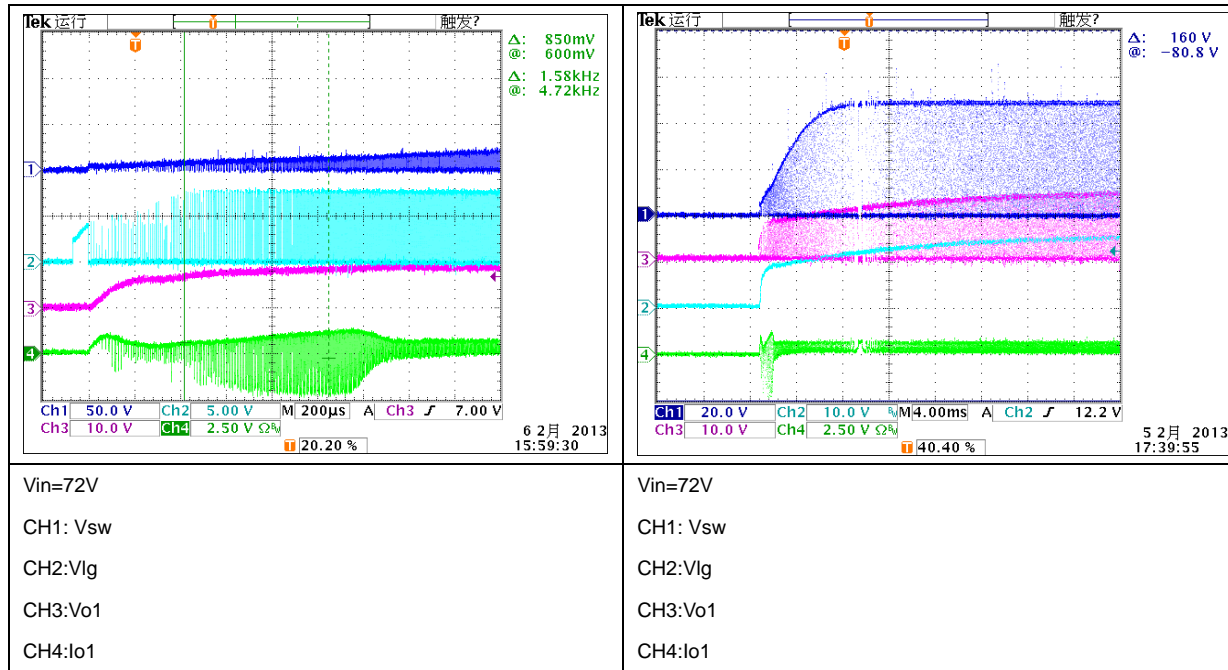
2.1 Start up and shut down waveform

Test condition: Vin=48V, Io1=0.3A, Io2=0.3A



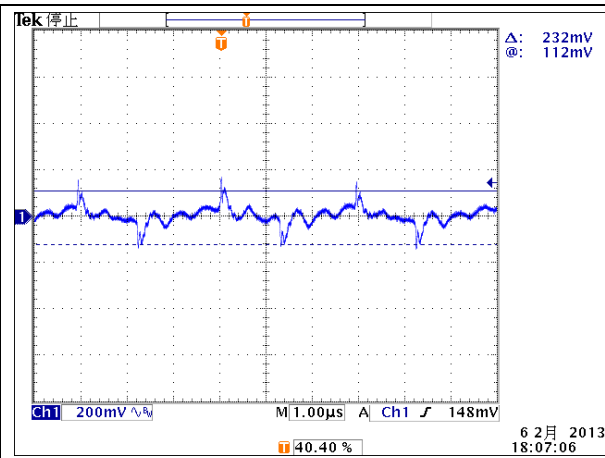
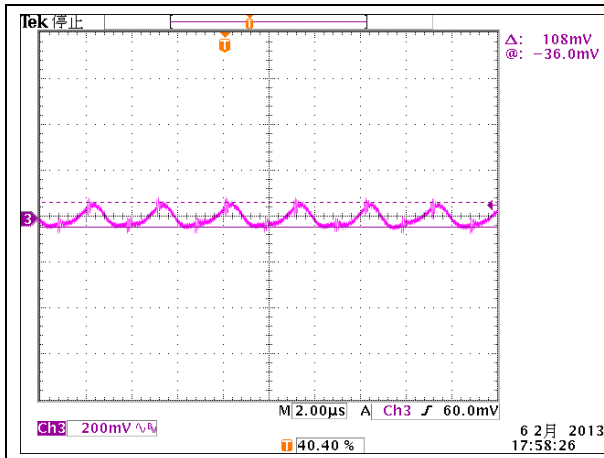
2.2 startup waveform

Test condition: $V_{in}=72V$ and $48V$, $I_{o1}=0.3A$, $I_{o2}=0.3A$



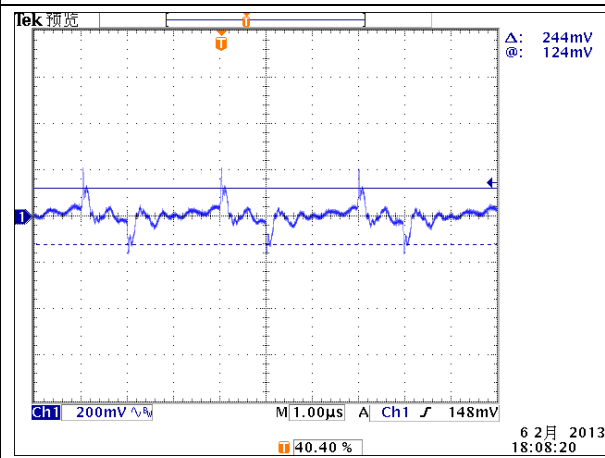
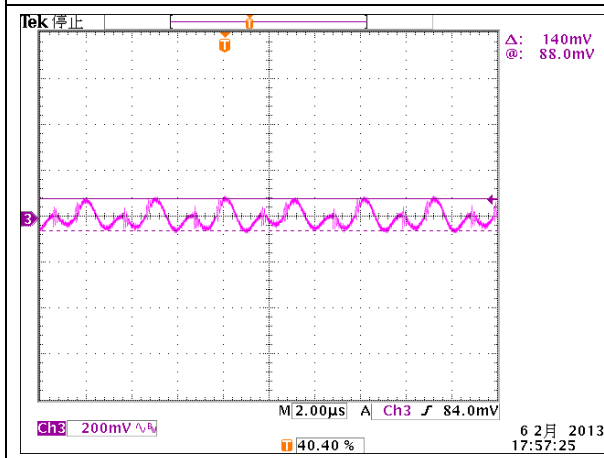
2.3 Output Ripple

Test condition: Vin=36V, 48V and 72V. Io1=0.3A, Io2=0.3A



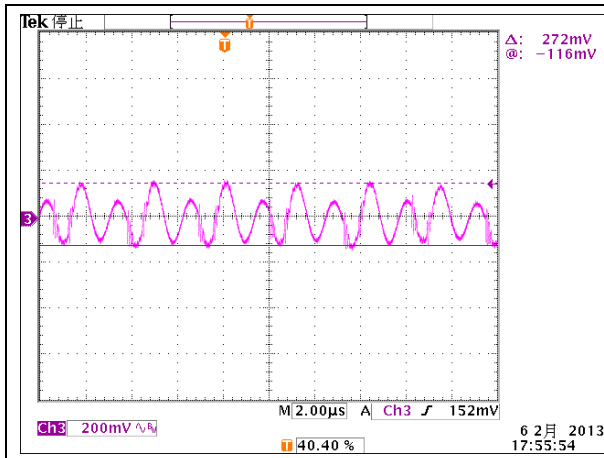
Vin=36V, Vo1 ripple

Vin=36V, Vo2 ripple

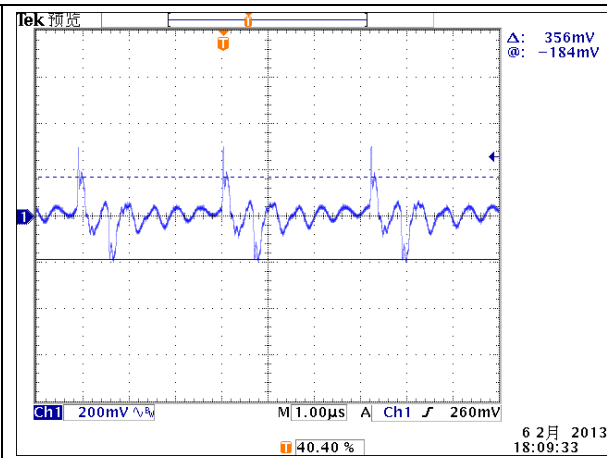


Vin=48V, Vo1 ripple

Vin=48V, Vo2 ripple



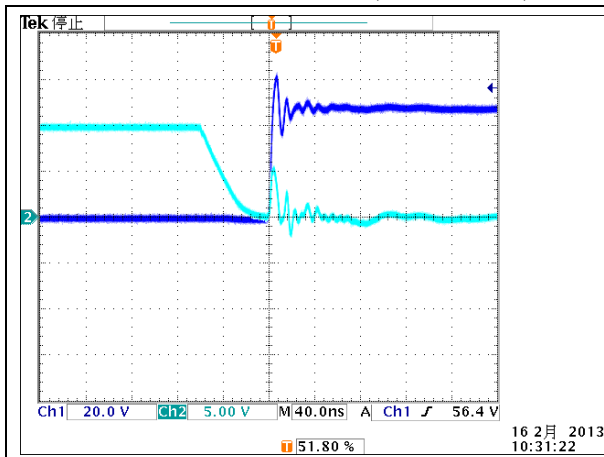
Vin=72V, Vo1 ripple



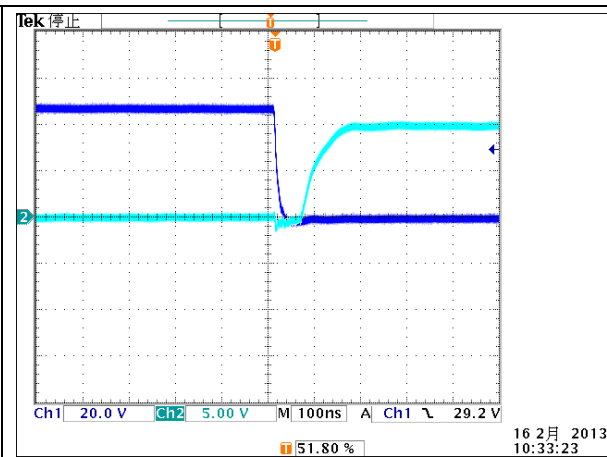
Vin=72V, Vo2 ripple

2.4 Vsw and VIg cross point waveform

Test condition: Vin=48V, Io1=0.3A, Io2=0.3A



Vsw rise time



Vsw fall time

CH1: Vsw	CH1: Vsw
CH2: Vlg	CH2: Vlg

3 CROSS REGULATION

Vi n=72V					Vi n=36V				
V _{o1} (V)	15.31	15.36	15.18	15.37	V _{o1} (V)	15.29	15.35	15.06	15.07
I _{o1} (A)	0.3	0	0.3	0	I _{o1} (A)	0.3	0	0.3	0
V _{o2} (V)	14.64	14.42	15.32	15.79	V _{o2} (V)	14.21	13.96	15.16	14.95
I _{o2} (A)	0.3	0.3	0	0	I _{o2} (A)	0.3	0.3	0	0
Vi n=48V					Vi n=24V				
V _{o1} (V)	15.29	15.35	15.12	15.34	V _{o1} (V)	15.25	15.31	14.95	14.99
I _{o1} (A)	0.3	0	0.3	0	I _{o1} (A)	0.3	0	0.3	0
V _{o2} (V)	14.49	14.24	15.34	15.38	V _{o2} (V)	12.82	12.88	15.12	14.75
I _{o2} (A)	0.3	0.3	0	0	I _{o2} (A)	0.3	0.3	0	0

4 EFFICIENCY CHARACTERISTICS

4.1 Efficiency data

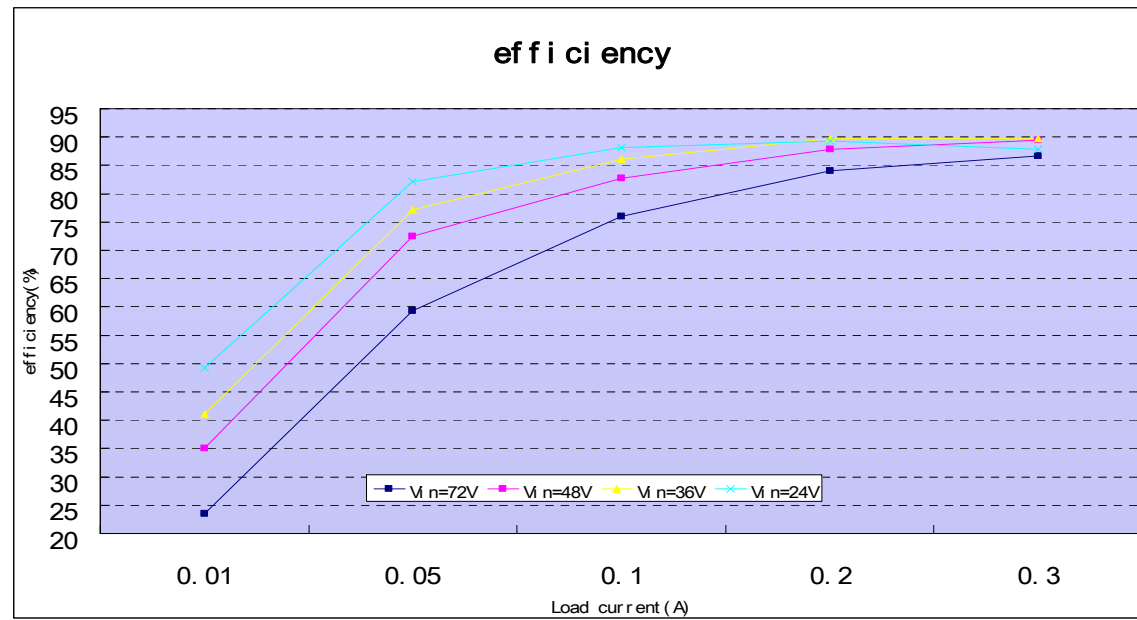
V _i n(V)	72	72. 16	72. 24	72. 28	72. 3
I _i n(A)	0. 144	0. 099	0. 055	0. 035	0. 018
V _o 1(V)	15. 31	15. 27	15. 33	15. 36	15. 36
I _o 1(A)	0. 3	0. 2	0. 1	0. 049	0. 01
V _o 2(V)	14. 64	14. 73	14. 88	15. 02	15. 25
I _o 2(A)	0. 3	0. 2	0. 1	0. 05	0. 01
eff i ci ency	0. 867	0. 84	0. 76	0. 594	0. 235

V _i n(V)	48	48. 1	48. 19	48. 23	48. 25
I _i n(A)	0. 208	0. 141	0. 075	0. 043	0. 018
V _o 1(V)	15. 29	15. 25	15. 2	15. 25	15. 36
I _o 1(A)	0. 3	0. 2	0. 1	0. 05	0. 01
V _o 2(V)	14. 49	14. 57	14. 68	14. 82	15. 11
I _o 2(A)	0. 3	0. 2	0. 1	0. 05	0. 01
eff i ci ency	0. 895	0. 879	0. 827	0. 725	0. 351

V _i n(V)	36	36. 1	36. 32	36. 42	36. 49
I _i n(A)	0. 274	0. 183	0. 095	0. 053	0. 02
V _o 1(V)	15. 29	15. 22	15. 15	15. 12	15. 12
I _o 1(A)	0. 3	0. 2	0. 1	0. 05	0. 01
V _o 2(V)	14. 21	14. 4	14. 56	14. 63	14. 82
I _o 2(A)	0. 3	0. 2	0. 1	0. 05	0. 01
eff i ci ency	0. 897	0. 897	0. 861	0. 771	0. 41

V _i n(V)	24	24. 42	24. 67	24. 8	24. 88
I _i n(A)	0. 399	0. 264	0. 134	0. 072	0. 024
V _o 1(V)	15. 25	15. 19	15. 07	15. 02	14. 77
I _o 1(A)	0. 3	0. 2	0. 1	0. 05	0. 01

4.2 Efficiency curve



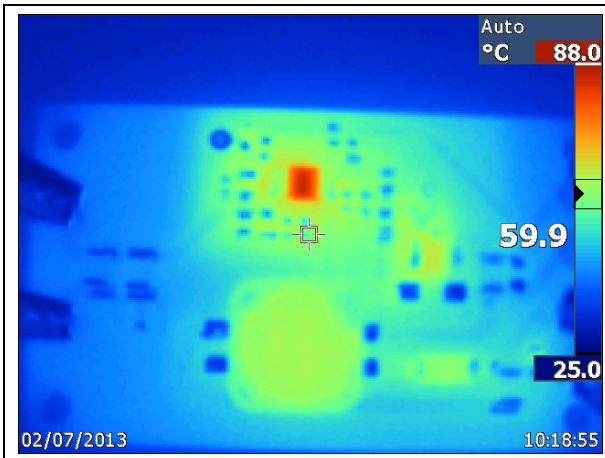
5 THERMAL CHARACTERISTICS

device temperature @ $V_n=72V$ and $T_a=25^\circ C$

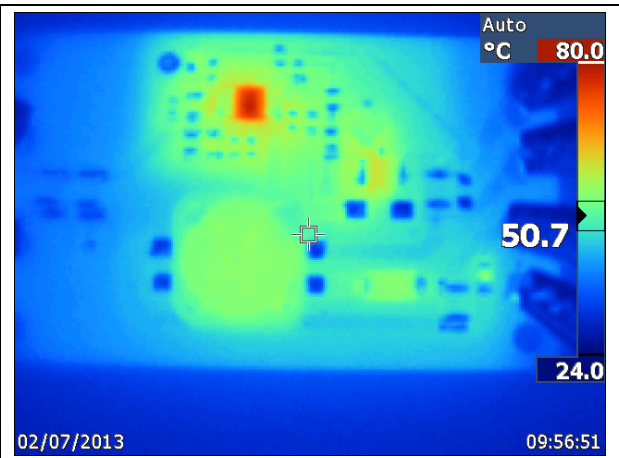
device case	U2	L1	Q1	D3
I o1=I o2=0.3A	88° C	62° C	65° C	60° C
I o1=I o2=0.25A	80° C	56° C	61° C	55° C
I o1=I o2=0.2A	77° C	53° C	58° C	53° C
I o1=I o2=0.15A	73° C	48° C	53° C	48° C

device temperature @ $V_n=48V$ and $T_a=25^\circ C$

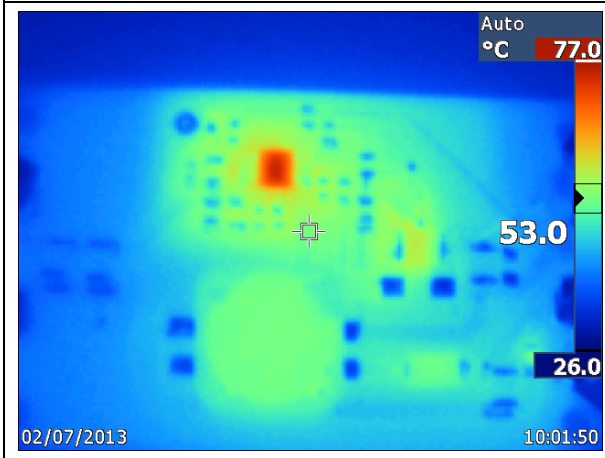
device case	U2	L1	Q1	D3
I o1=I o2=0.3A	66° C	59° C	48° C	57° C
I o1=I o2=0.25A	62° C	53° C	45° C	52° C
I o1=I o2=0.2A	56° C	45° C	42° C	47° C
I o1=I o2=0.15A	55° C	43° C	40° C	44° C



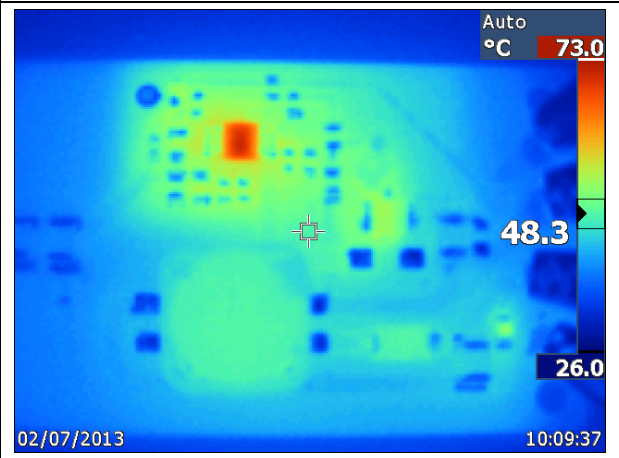
Vin=72V, Io1=Io2=0.3A



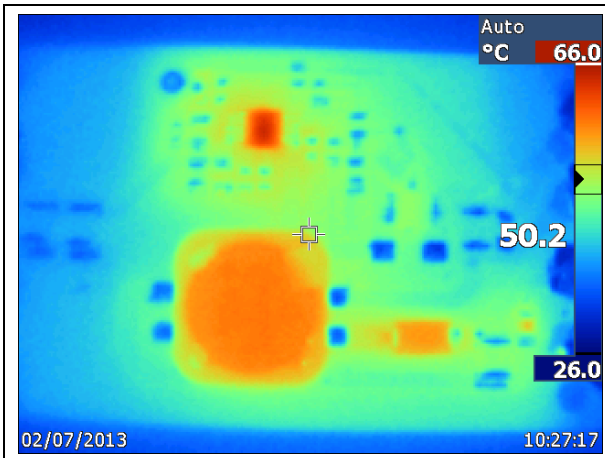
Vin=72V, Io1=Io2=0.25A



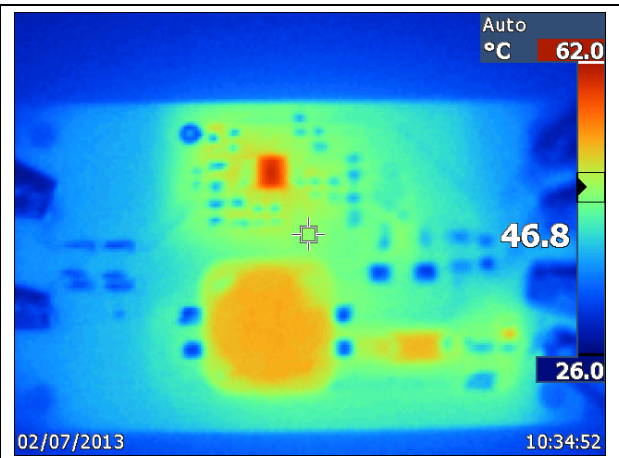
Vin=72V, Io1=Io2=0.2A



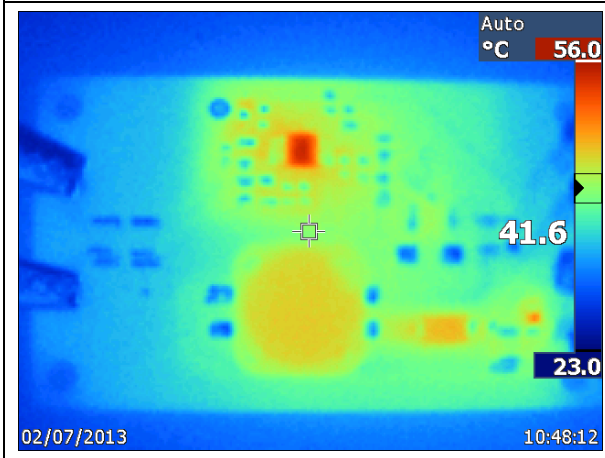
Vin=72V, Io1=Io2=0.15A



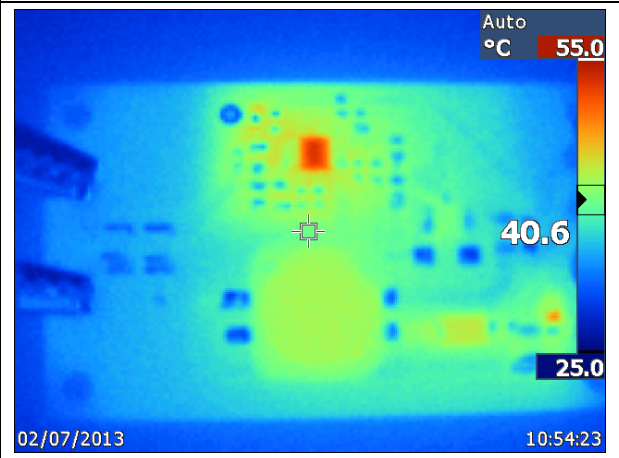
Vin=48V, Io1=Io2=0.3A



Vin=48V, Io1=Io2=0.25A



Vin=48V, Io1=Io2=0.2A



Vin=48V, Io1=Io2=0.15A

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